

Notice of References Cited	Application/Control No. 10/620,917	Applicant(s)/Patent Under Reexamination MADURAWA ET AL.	
	Examiner Ly D Pham	Art Unit 2818	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,573,138 B1	06-2003	Pass et al.	438/257
*	B	US-5,581,504 A	12-1996	Chang, Shang-De T.	365/185.17
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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